

**Notice of References Cited**

Application/Control No.

09/180,132

Applicant(s)/Patent Under  
Reexamination  
KIM ET AL.

Examiner

Barbara P Badio, Ph.D.

Art Unit

1616

Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification	
X	A	US-5,446,036	08-1995	Scholz et al.	514	175
	B	US-				
	C	US-				
	D	US-				
	E	US-				
	F	US-				
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**FOREIGN PATENT DOCUMENTS**

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